

June 2012

FDMC86160

N-Channel Power Trench[®] MOSFET 100 V, 43 A, 14 m Ω

Features

- Max $r_{DS(on)}$ = 14 m Ω at V_{GS} = 10 V, I_D = 9 A
- Max $r_{DS(on)} = 23 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 7 \text{ A}$
- High performance technology for extremely low r_{DS(on)}
- Termination is Lead-free and RoHS Compliant

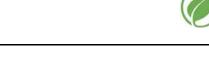
General Description

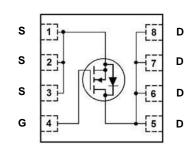
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for applications where ulta low R_{DS} (on) is required in small spaces such as High performance VRM, POL and orring functions.

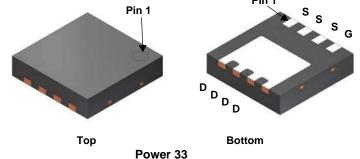
Applications

- Bridge Topologies
- Synchronous Rectifier









MOSFET Maximum Ratings T_A = 25 ℃ unless otherwise noted

Symbol		Paramet	ter		Ratings	Units
V _{DS}	Drain to Source \	Voltage			100	V
V _{GS}	Gate to Source V	/oltage			±20	V
	Drain Current	-Continuous	T _C = 25 ℃		43	
I_D		-Continuous	T _A = 25 ℃	(Note 1a)	9	Α
		-Pulsed			50	
E _{AS}	Single Pulse Ava	lanche Energy		(Note 3)	181	mJ
D	Power Dissipatio	n	T _C = 25 ℃		54	W
P_{D}	Power Dissipatio	n	T _A = 25 ℃	(Note 1a)	2.3	VV
T _J , T _{STG}	Operating and St	orage Junction Temperat	ure Range		-55 to +150	C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	2.3	%\W
$R_{\theta,IA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86160	FDMC86160	Power33	Power33 13 " 12 mm		3000 units

Electrical Characteristics $T_J = 25 \text{ } \text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		73		mV/℃
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μΑ
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2	2.9	4	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		-9		mV/℃
		V _{GS} = 10 V, I _D = 9 A		11.2	14	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 6 \text{ V}, I_D = 7 \text{ A}$		16	23	mΩ
, ,		$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}, T_J = 125 ^{\circ}\text{C}$		21	26	
9 _{FS}	Forward Transconductance	$V_{DD} = 10 \text{ V}, I_{D} = 9 \text{ A}$		43		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 50.V.V 0.V	968	1290	pF
Coss	Output Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	241	320	рF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1011 12	11	20	pF
R_{a}	Gate Resistance		0.6	2.5	Ω

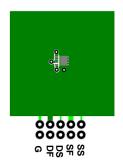
Switching Characteristics

t _{d(on)}	Turn-On Delay Time			9.7	19	ns
t _r	Rise Time	V _{DD} = 50 V, I _D = 9	$V_{DD} = 50 \text{ V}, I_D = 9 \text{ A},$		10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		16	30	ns
t _f	Fall Time			3.4	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V _{GS} = 0 V to 10 V		15	22	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to 6 V}$	$V_{DD} = 50 \text{ V},$ $I_{D} = 9 \text{ A}$	9.8	15	nC
Q_{gs}	Total Gate Charge		I _D = 9 A	4.4		nC
Q_{gd}	Gate to Drain "Miller" Charge			3.5		nC

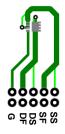
Drain-Source Diode Characteristics

	$V_{GS} = 0 \text{ V}, I_{S} = 9 \text{ A}$	(Note 2)	0.79	1.3	V	
v SD	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 1.9 \text{ A}$	(Note 2)	0.72	1.2	V
t _{rr}	Reverse Recovery Time	I - 0 A di/dt - 100 A/		47	75	ns
Q _{rr}	Reverse Recovery Charge	I _F = 9 A, di/dt = 100 A/μs		45	73	nC

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 125 °C/W when mounted on a minimum pad of 2 oz copper

^{2.} Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

^{3.} E_{AS} of 181 mJ is based on starting $T_{J} = 25$ °C, L = 3 mH, $I_{AS} = 11$ A, $V_{DD} = 100$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 35$ A.

Typical Characteristics $T_J = 25 \text{ } \text{C}$ unless otherwise noted

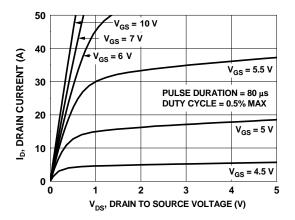


Figure 1. On-Region Characteristics

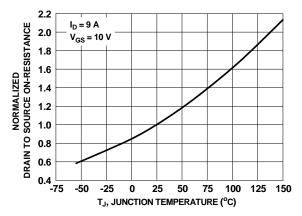


Figure 3. Normalized On-Resistance vs Junction Temperature

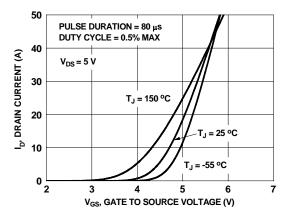


Figure 5. Transfer Characteristics

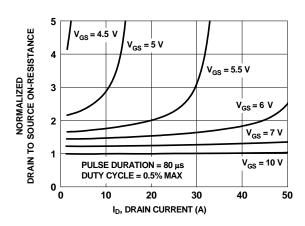


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

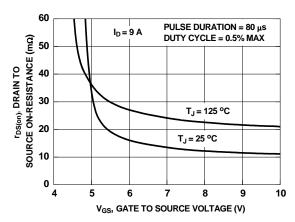


Figure 4. On-Resistance vs Gate to Source Voltage

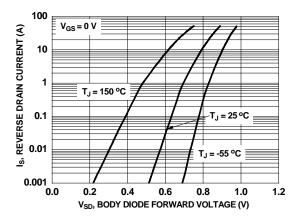


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25 \ {\rm C}$ unless otherwise noted

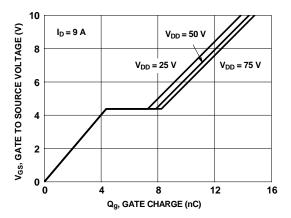


Figure 7. Gate Charge Characteristics

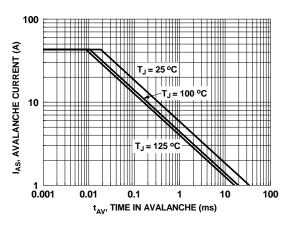


Figure 9. Unclamped Inductive Switching Capability

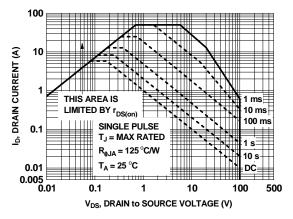


Figure 11. Forward Bias Safe Operating Area

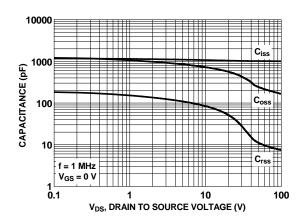


Figure 8. Capacitance vs Drain to Source Voltage

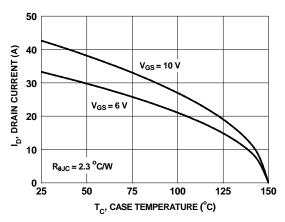


Figure 10. Maximum Continuous Drain Current vs Case Temperature

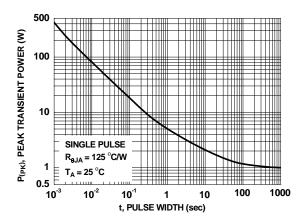


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25 \text{ } \text{C}$ unless otherwise noted

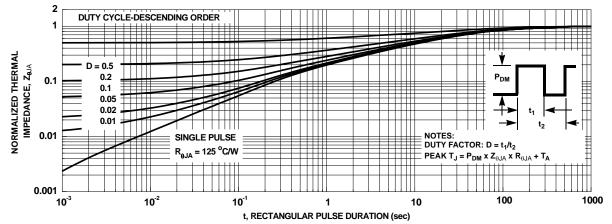
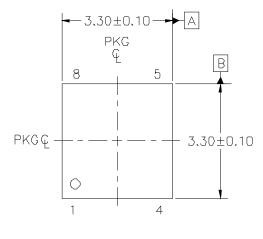
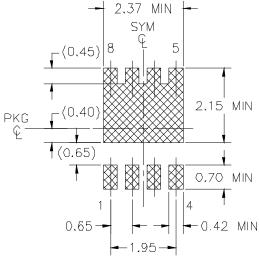
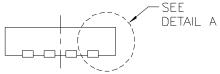


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

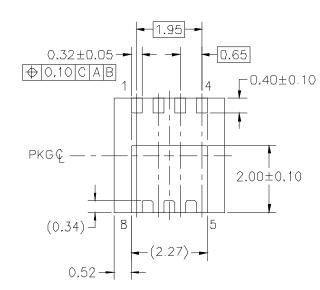
Dimensional Outline and Pad Layout





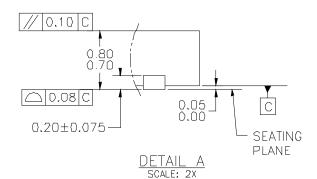


LAND PATTERN RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA, DATED OCTOBER 2002,
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0,10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.







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